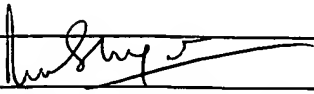


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250583US6YA DIV		SERIAL NO. 10/803,994	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shinya NISHIMOTO, et al.			
				FILING DATE March 19, 2004		GROUP 1763	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
L	AA	6,364,949	4/2002	Or et al.			
L	AB	5,911,852	6/1999	Katayama et al.			
L	AC	5,074,456	12/1991	Degner et al.			
L	AD	4,612,077	9/1986	Tracy et al.			
L	AE	6,182,603	2/2001	Shang et al.			
L	AF	2003/0010446	1/2003	Kajiyama et al.			
L	AG	2001/0003271	6/2001	Otsuki			
L	AH	2002/0076508	6/2002	Chiang et al.			
L	AI	6,368,987	4/2002	Kopacz et al.			
L	AJ	2004/0072426	4/2004	Jung			
L	AK	6,383,964	5/2002	Nakahara et al.			
L	AL	6,123,791	9/2000	Han et al.			
L	AM	6,170,429	1/2001	Schoepp et al.			
L	AN	6,096,161	8/2000	Kim et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
L	AO	EP 1 156 130	11/2001	Europe			
L	AP	JP 10-004083	1/1998	Japan (w/ English Abstract)			
L	AQ	JP 2001-226773	8/2001	Japan (w/ English Abstract)			
L	AR	JP 2000-303180	10/2000	Japan (w/ English Abstract)			
L	AS	EP 0 814 495	12/1997	Europe			
L	AT	JP 05-198532	8/1993	Japan (w/ English Abstract)			
L	AU	JP 10-214819	8/1998	Japan (w/ English Abstract)			
L	AV	JP 2002-151473	5/2002	Japan (w/ English Abstract and Computer Translation)		X	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
L	AW	JIS Using Series, "Spraying Techniques Manual.", p. 95 (Oct. 30, 1998, Japanese Standard Association), with English Translation					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered 02/09/06			
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
L	AA	5,362,335	11/1994	Rungta			
L	AB	5,952,060	9/1999	Ravi			
L	AC	5,680,013	10/1997	Domfest et al.			
L	AD	5,494,713	2/1996	Ootuki			
L	AE	5,366,585	11/1994	Robertson et al.			
L	AF	5,000,113	3/1991	Wang et al.			
L	AG	5,334,462	8/1994	Vine et al.			
L	AH	6,830,622	12/2004	O'Donnell et al.			
L	AI	6,176,969	1/2001	Park et al.			
L	AJ	5,919,332	7/1999	Koshiishi et al.			
L	AK	2004/0035364	2/2004	Tomoyoshi et al.			
L	AL	5,868,848	2/1999	Tsukamoto			
L	AM	6,110,287	8/2000	Arai et al.			
L	AN	6,129,808	10/2000	Wicker et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
L	AO	WO 02/39495	5/2002	WIPO (Japan w/ English Abstract)			
L	AP	EP 1 069 603	1/2001	Europe			
L	AQ	JP 07-245295	9/1995	Japan (w/ English Abstract)			
L	AR	EP 0 841 838	5/1998	Europe			
L	AS	WO 99/50886	10/1999	WIPO			
L	AT	EP 0 573 057	12/1993	Europe			
L	AU	JP 2000-124197	4/2000	Japan (w/ English Abstract)			
L	AV	EP 1 081 749	3/2001	Europe			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
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L	AA	6,264,788	7/2001	Tomoyasu et al.			
L	AB	6,394,026	5/2002	Wicker et al.			
L	AC	6,444,083	9/2002	Steger et al.			
L	AD	6,514,377	2/2003	Morimoto			
L	AE	6,527,911	3/2003	Yen et al.			
L	AF	6,533,910	3/2003	O'Donnell et al.			
L	AG	6,537,429	3/2003	O'Donnell et al.			
L	AH	6,544,380	4/2003	Tomoyasu et al.			
L	AI	6,583,064	6/2003	Wicker et al.			
L	AJ	6,733,620	5/2004	Sugiyama et al.			
L	AK	2002/0086501	7/2002	O'Donnell et al.			
L	AL	2002/0086545	7/2002	O'Donnell et al.			
L	AM	2002/0086553	7/2002	O'Donnell et al.			
L	AN	2002/0142611	10/2002	O'Donnell et al.			

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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
L	AO	JP 04-238882	8/1992	Japan (w/ English Abstract)		
L	AP	JP 01-312087	12/1989	Japan (w/ English Abstract)		
L	AQ	JP 08-041309	2/1996	Japan (w/ English Abstract)		
L	AR	JP 08-081777	3/1996	Japan (w/ English Abstract)		
L	AS	JP 08-268751	10/1996	Japan (w/ English Abstract)		
L	AT	JP 07-226378	8/1995	Japan (w/ English Abstract)		
L	AU	JP 64-039728	2/1989	Japan (w/ English Abstract)		
L	AV	JP 03-115535	5/1991	Japan (w/ English Abstract)		

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

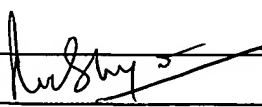
	AW	
	AX	
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☐ Additional References sheet(s) attached

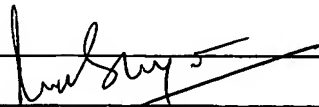
Examiner

Date Considered 02/09/06

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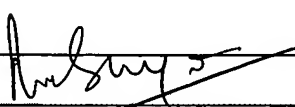
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250583US6YA DIV		SERIAL NO. 10/803,994	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shinya NISHIMOTO, et al.			
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
L	AA	2003/0084848	5/2003	Long			
L	AB	2004/0026372	2/2004	Takenaka et al.			
L	AC	2004/0060516	4/2004	Nishimoto et al.			
L	AD	2004/0060656	4/2004	Saigusa et al.			
L	AE	2004/0060657	4/2004	Saigusa et al.			
L	AF	2004/0060658	4/2004	Nishimoto et al.			
L	AG	2004/0060661	4/2004	Nishimoto et al.			
L	AH	2004/0061447	4/2004	Saigusa et al.			
L	AI	2004/0063333	4/2004	Saigusa et al.			
L	AJ	2004/0125359	7/2004	Ludviksson et al.			
L	AK	6,335,293	1/2002	Luo et al.			
L	AL	6,221,202	4/2001	Walko, II			
L	AM	5,900,064	5/1999	Kholodenko			
L	AN	5,641,375	6/1997	Nitescu et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
L	AO	JP 05-117064	5/1993	Japan (w/ English Abstract and Corresponding U.S. Patent 5,551,190)			
L	AP	JP 05-238859	9/1993	Japan (w/ English Abstract and Corresponding U.S. Patent 5,725,960)			
L	AQ	JP 06-057396	3/1994	Japan (w/ English Abstract)			
L	AR	JP 06-136505	5/1994	Japan (w/ English Abstract)			
L	AS	JP 06-142822	5/1994	Japan (w/ English Abstract)			
L	AT	JP 07-126827	5/1995	Japan (w/ English Abstract)			
L	AU	JP 07-176524	7/1995	Japan (w/ English Abstract)			
L	AV	JP 08-037180	2/1996	Japan (w/ English Abstract)			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner						Date Considered 02/09/66	
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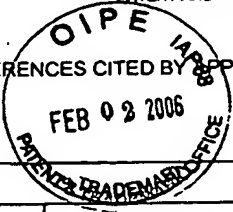
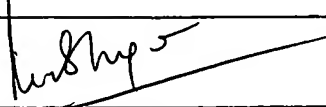
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250583US6YA DIV		SERIAL NO. 10/803,994	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shinya NISHIMOTO, et al.			
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
L	AA	6,383,333	5/2002	Haino et al.			
L	AB	6,590,660	7/2003	Jung et al.			
L	AC	6,570,654	5/2003	Jung et al.			
L	AD	6,519,037	2/2003	Jung et al.			
L	AE	6,373,573	4/2002	Jung et al.			
L	AF	6,246,479	6/2001	Jung et al.			
L	AG	5,851,343	12/1998	Hsu et al.			
L	AH	6,210,486	4/2001	Mizukami et al.			
L	AI	2002/0086118	7/2002	Chang et al.			
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L	AK	4,593,007	6/1986	Novinski			
L	AL	5,985,102	11/1999	Leiphart			
L	AM	6,106,625	8/2000	Koai et al.			
L	AN	6,123,804	9/2000	Babassi et al.			
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
L	AO	JP 08-339895	12/1996	Japan (w/ English Abstract)			
L	AP	JP 09-069554	3/1997	Japan (w/ English Abstract)			
L	AQ	JP 09-272987	10/1997	Japan (w/ English Abstract)			
L	AR	JP 10-045461	2/1998	Japan (w/ English Abstract)			
L	AS	JP 10-045467	2/1998	Japan (w/ English Abstract)			
L	AT	JP 11-080925	3/1999	Japan (w/ English Abstract)			
L	AU	JP 11-207161	8/1999	Japan (w/ English Abstract)			
L	AV	JP 2001-031484	2/2001	Japan (w/ English Abstract and Corresponding U.S. Patent No. 6,695,929)			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				Date Considered 02/09/06			
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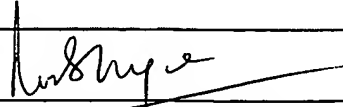
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 250583US6YA DIV		SERIAL NO. 10/803,994	
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
L	AA	6,265,757	7/2001	Brady et al.			
L	AB	6,143,646	11/2000	Wetzel			
L	AC	2002/0090464	7/2002	Jiang et al.			
L	AD	4,469,619	9/1984	Ohno et al.			
L	AE	5,426,310	6/1995	Tamada et al.			
L	AF	5,556,501	9/1996	Collins et al.			
L	AG	5,614,055	3/1997	Fairbairn et al.			
L	AH	5,944,902	8/1999	Redeker et al.			
L	AI	5,994,662	11/1999	Murugesu			
L	AJ	5,894,887	4/1999	Kelsey et al.			
L	AK	5,879,575	3/1999	Tepman et al.			
L	AL	5,759,360	6/1998	Ngan et al.			
L	AM	5,798,016	8/1998	Oehrlein et al.			
L	AN	6,139,983	10/2000	Ohashi et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
L	AO	JP 10-251871	9/1998	Japan (w/English Abstract)			
L	AP	WO 02/48421	6/2002	WIPO (Japan w/English Abstract)			
L	AQ	WO 01/42526	6/2001	WIPO (Japan w/English Abstract and Corresponding U.S. Patent 6,783,863)			
L	AR	WO 2004/030011	4/2004	WIPO			
L	AS	WO 2004/030012	4/2004	WIPO			
L	AT	WO 2004/030013	4/2004	WIPO			
L	AU	WO 2004/030014	4/2004	WIPO			
L	AV	WO 2004/030015	4/2004	WIPO			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner 					Date Considered 0409/06		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

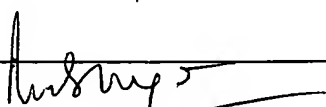
check

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
L	AA	5,484,752	1/1996	Waku et al.			
L	AB	5,895,586	4/1999	Kaji et al.			
L	AC	6,120,640	9/2000	Shih et al.			
L	AD	6,738,862	5/2004	Ross et al.			
L	AE	6,783,863	8/2004	Harada et al.			
L	AF	6,837,966	1/2005	Nishimoto et al.			
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L	AI	6,641,697	11/2003	Han et al.			
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L	AK	2003/0200929	10/2003	Otsuki			
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	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
L	AO	WO 2004/030020	4/2004	WIPO			
L	AP	WO 2004/030426	4/2004	WIPO			
L	AQ	WO 2004/095530	11/2004	WIPO			
L	AR	WO 2004/095532	11/2004	WIPO			
L	AS	EP 0 508 731	10/1992	Europe			
L	AT	JP 2001-164354	6/2001	Japan (w/ English Abstract, Computer Translation and Certified Translation)	X		
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
L	AA	5,551,190	9/1996	Yamagishi et al.			
R	AB	2005/0103268	5/2005	Nishimoto et al.			
R	AC	2004/0216667	11/2004	Mitsuhashi et al.			
	AD						
	AE						
	AF						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
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	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner 					Date Considered 02/09/06		
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				FILED March 19, 2004 GROUP 1763			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,955,182	09/1999	Yasuda et al.			
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
L	AB	1 156 130	11/21/2001	Europe (in English; Previously filed with International Search Report)			
L	AC	10-004083	01/06/1998	Japan (Japanese language document filed in previous IDS along with International Search Report; English Abstract and Computer translation filed herewith)			
L	AD	2001-226773	08/21/2001	Japan (Japanese language document filed in previous IDS along with International Search Report; English Abstract and Corresponding US 2001/0003271 A1 filed herewith)			
L	AE	2000-303180	10/31/2000	Japan (Japanese language document filed in previous IDS along with International Search Report; English Abstract and Corresponding US 2003/0010446 A1 filed herewith)			
L	AF	0 814 495	06/1997	Europe (in English; Previously filed with International Search Report)			
L	AG	05-198532	08/1993	Japan (Japanese language document filed in previous IDS or Cited by Examiner in S.N. 10/259,858. English Abstract and Computer translation filed herewith)			
L	AH	10-214819	08/1998	Japan (Japanese language document filed in previous IDS or Cited by Examiner in S.N. 10/259,858. English Abstract and Computer translation filed herewith)			
L	AI	2002-151473	05/2002	Japan (Japanese language document filed in previous IDS along with International Search Report or Cited by Examiner in S.N. 10/259,858. English Abstract and Corresponding US 2004/0035364 A1 filed herewith)			
L	AJ	02/39495	05/16/2002	WIPO (Japanese language document filed in previous IDS along with International Search Report. English Abstract and Corresponding US 2004/0035364 A1 filed herewith)			
L	AK	1 069 603	01/17/2001	Europe (in English; Previously filed with International Search Report)			
L	AL	07-245295	09/1995	Japan (Japanese language document filed in previous IDS or Cited by Examiner in S.N. 10/259,380. English Abstract and Computer translation filed herewith)			
L	AM	0 841 838	05/1998	Europe (in English; Previously filed with International Search Report)			
L	AN	99/50886	10/1999	WIPO (in English; Previously filed with International Search Report)			
L	AO	0 573 057	12/1993	Europe (in English)			
L	AP	2000-124197	04/28/2000	Japan (Japanese language document filed in previous IDS along with International Search Report. English Abstract and Computer translation filed herewith)			
L	AQ	1 081 749	07/03/2001	Europe (in English; Previously filed with International Search Report)			
L	AR	4-238882	08/1992	Japan (Japanese language document filed in previous IDS along with International Search Report. Certified English translation filed herewith)			
L	AS	1-312087	12/1989	Japan (Japanese language document filed in previous IDS along with International Search Report. English Abstract and Corresponding US Patent 4,968,374 filed herewith)			
L	AT	08-041309	02/1996	Japan (Japanese language document filed in previous IDS along with International Search Report. English Abstract and Computer translation filed herewith)			
					<input checked="" type="checkbox"/> Additional References sheet(s) attached		
Examiner 					Date Considered 02/11/06		
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L	AV	08-268751	10/15/1996	Japan (Japanese language document filed in previous IDS along with Statement of Relevancy. English Abstract and Computer translation filed herewith)			
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L	AX	64-039728	02/1989	Japan (Japanese language document filed in previous IDS. Certified English translation filed herewith)			
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L	BA	05-238859	09/1993	Japan (Japanese language document filed in previous IDS. English Abstract and Computer translation filed herewith)			
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					<input checked="" type="checkbox"/> Additional References sheet(s) attached		
Examiner 					Date Considered 02/11/06		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shinya NISHIMOTO, et al.			
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R	BS	0 508 731	10/14/1992	Europe (in English; Cited in Advisory Action in 238231US2CONT, S.N.10/444,957)			
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L	CT	6,852,433	02/2005	Maeda, Takao			
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DO	Production drawing for Deposition Shield, Upper believed to be sold in the U.S. on April 12, 2000
DP	Production drawing for Deposition Shield believed to be sold in the U.S. prior to September 30, 2001.
DQ	Production drawing for Upper Electrode believed to be sold in the U.S. prior to September 30, 2001
	<input checked="" type="checkbox"/> Additional References sheet(s) attached
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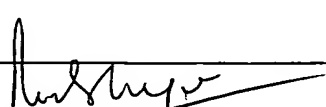
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L	DS	6,663,714	12/203	Mizuno et al.			
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	AU					
	AV					

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	AW		
	AZ		<input type="checkbox"/> Additional References sheet(s) attached
Examiner			Date Considered 02/11/06

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